```
% INPUT Matrices: ndataseq01060216 and ndataseq10060216 from crop
       simulation models with Columns
    % 1 = cell30m/Unique Cell ID
 4
    % 2 = Replication
    % 3 = Wheat Area in Cell (ha)
    % 4 = Wheat Yield (kg/ha) for Weeding
    % 5 = Wheat Yield (kg/ha) for No weeding
    % OUTPUT Matrix: RA with columns
9
10
    # % 1 = cellID
11
    # % 2 = Comparison Technology ID
12
    # % 3 = Base Technology ID
13
          4 = Mean Yield for Comp
    # % 5 = Standard Deviation of Yield for Comp
15
    # % 6 = CV of Yield for Comp
          7 = Maximum Yield for Comp
16
    # % 8 = Minimum Yield for Comp
17
18
    # % 9 = Probability of Crop Failure for Comp
19
    \# % 10 = Min Proportion for Comp to SOSD Base
20
    # % 11 = Mean Yield for Base
21
    # % 12 = Standard Deviation of Yield for Base
    # % 13 = CV of Yield for Base
23
    # % 14 = Maximum Yield for Base
    # % 15 = Minimum Yield for Base
    # % 16 = Probability of Crop Failure for Base
25
    # % 17 = Min Proportion for Base to SOSD Comp
27
    # % 18 = Difference in mean Comp - Base
28
    # % 19 = Difference in standard deviation Comp - Base
    # % 20 = Difference in CV Comp - Base
29
    # % 21 = Difference in Prob of Crop Failure Comp - Base
    \# % 22 = Min Proportion for Comp to SOSD Base divided by average base yield
31
    # % 23 = Min Proportion for Base to SOSD Comp divided by average base yield
# % 24 = Comp More Risky (-1)/less Risky (1)/ Indeterminant (0) compared to Base
32
33
34
    # % 25 = Wheat Area
35
36
     % For Year Sequence 1
     % Compare 40 kgs versus 0 kgs N for Each Unimproved and Improved Varieties
37
     RA_yearseq_01 = ConstRiskThresh(ndataseq01060216, 4, 5);
39
40
41
    LEN
                  = length(RA_yearseq_01);
                  = ones (LEN,\overline{1});
42
     apones
43
44
    clear apones LEN;
45
46
47
    RA = [RA\_yearseq\_01];
48
49
```

50